

Notic of References Cited	Application/Control No. 10/005,223	Applicant(s)/Patent Under Reexamination SHON ET AL.	
	Examiner Amy He	Art Unit 2858	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,848,218	11-1974	Wakabayashi et al.	338/35
	B	US-5,847,261	12-1998	Lee	73/1.07
	C	US-6,429,265	08-2002	Nishida	525/329.5
	D	US-6,430,379	08-2002	Takahashi et al.	399/44
	E	US-5,661,405	08-1997	Simon et al.	324/697
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages
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	V	
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	X	

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